

# **INFORMATION**

**MODEL :** SG-210SCBA

**INFO. No. :** A13-1183-1B

**DATE :** Mar. 6. 2014

**SEIKO EPSON CORPORATION**

**8548 Naka-minowa  
Minowa-machi Kamiina-gun  
Nagano-ken  
399-4696 Japan**

## INTRODUCTION

1. The contents is subject to change without notice.  
Please exchange the specification sheets regarding the product's warranty.
2. This sheet is not intended to guarantee or provide an approval of implementation of industrial patents.
3. We have prepared this sheet as carefully as possible.  
If you find it incomplete or unsatisfactory in any respect, We would welcome your comments.

This product is compliant with RoHS Directive.

This Product supplied (and any technical information furnished, if any) by Seiko Epson Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes. Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use. We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

This SG-210SCBA is authorized for Use of motor monitor for automobile only.

## Model

The model is SG-210SCBA.

## Contents

Item No.	Item	Page
[ 1 ]	Absolute maximum ratings	2
[ 2 ]	Operating range	2
[ 3 ]	Frequency characteristics	2
[ 4 ]	Terminal assignment	3
[ 5 ]	Electrical characteristics	4
[ 6 ]	Test circuit	5
[ 7 ]	Timing chart	6-7
[ 8 ]	Environmental and mechanical characteristics	8
[ 9 ]	Dimensions and marking layout	9
[ 10 ]	Notes	10
[ 11 ]	Recommendable patterning	11

### [ 1 ] Absolute maximum ratings SCB

Parameter	Symbol	Value	Unit	Note
Supply voltage	V <sub>CC-GND</sub>	-0.3 to +5.0	V	
Storage temperature *	T <sub>stg</sub>	-40 to +125	°C	Stored as bare product after unpacking.
Input voltage	V <sub>IN</sub>	-0.3 to V <sub>CC</sub> +0.3	V	$\overline{\text{ST}}$ Terminal

\* Concerning the frequency change, please refer [8] Environmental and mechanical characteristics.

### [ 2 ] Operating range

Parameter	Symbol	Value			Unit	Note
		Min.	Typ.	Max.		
Supply voltage	V <sub>CC</sub>	2.7	3.3	3.6	V	
Supply voltage	GND	0.0	0.0	0.0	V	
Input voltage	V <sub>IN</sub>	GND	-	V <sub>CC</sub>	V	
Operating temperature	T <sub>use</sub>	-40	+25	+125	°C	Z
Output load condition	L <sub>CMOS</sub>	-	-	15	pF	

- Start up time(0 %V<sub>CC</sub>→90 %V<sub>CC</sub>) of power source should be more than 150 μs.
- By-pass capacitor (0.01 μF to 0.1 μF) is connected near V<sub>CC</sub> between V<sub>CC</sub> and GND.  
(Refer to [ 11 ] Recommendable patterning)

### [ 3 ] Frequency characteristics

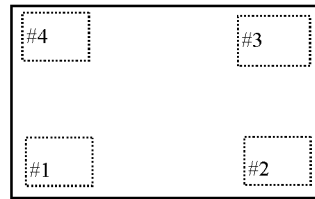
Output frequency (f<sub>0</sub>) ..... 10.000 MHz

Parameter	Symbol	Value[1 × 10 <sup>-6</sup> ]	Note
Frequency tolerance *	f <sub>tol</sub> (OSC)	Z : ±100	T <sub>use</sub> =-40 °C to +125°C
Aging	F <sub>aging</sub>	± 3	T <sub>use</sub> =+25 °C, V <sub>CC</sub> =3.3 V First year

\* This includes initial frequency tolerance, temperature characteristics, input voltage characteristics, and load characteristics, but excludes aging.

## [ 4 ] Terminal assignment

Top View



Terminal name	Terminal No.	Terminal type.
$\overline{\text{ST}}$	1	INPUT
GND	2	—
OUT	3	OUTPUT
Vcc	4	—

$\overline{\text{ST}}$  pin : High or open. → Specified frequency output = enable.

$\overline{\text{ST}}$  pin : Low. → Output is high impedance = disabled.

\* When the  $\overline{\text{ST}}$  terminal is not controlled, it should be connected to the Vcc terminal.

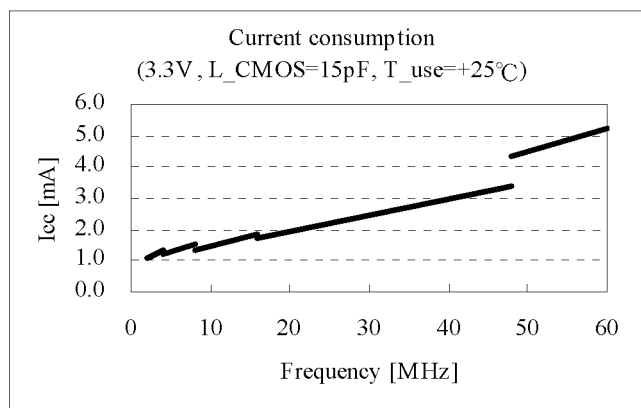
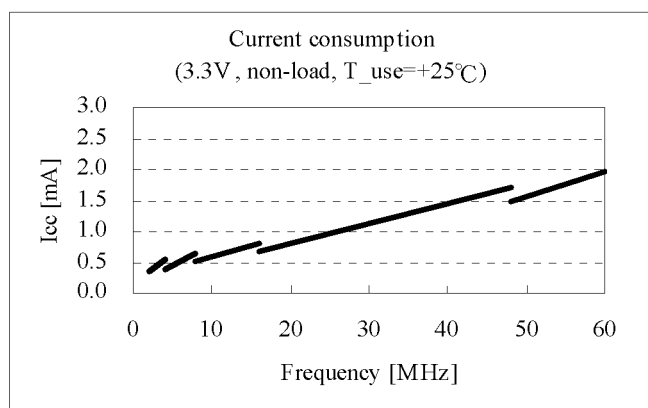
## [ 5 ] Electrical characteristics

(Please see page 2 [2] Operating range)

Parameter	Symbol	Value		Unit	Note
		Min.	Max.		
Start up time	t <sub>osc</sub>	-	3	ms	t=0 at 90 %V <sub>CC</sub>
Current consumption	I <sub>CC</sub>	-	3.0	mA	No load
		-	4.0		No load Ta<+125 °C
Standby current	I <sub>std</sub>	-	1.0	μA	$\overline{ST} = GND$
		-	3.0		$\overline{ST} = GND$ Ta<+125 °C
Output rise time	t <sub>r</sub>	-	3.0	ns	20 %V <sub>CC</sub> → 80 %V <sub>CC</sub>
		-	7.0		20 %V <sub>CC</sub> → 80 %V <sub>CC</sub> Ta<+125 °C
Output fall time	t <sub>f</sub>	-	3.0	ns	80 %V <sub>CC</sub> → 20 %V <sub>CC</sub>
		-	7.0		80 %V <sub>CC</sub> → 20 %V <sub>CC</sub> Ta<+125 °C
Symmetry	SYM	45	55	%	50 %V <sub>CC</sub> Level
		40	60		50 %V <sub>CC</sub> Level 50 %V <sub>CC</sub> Level
High level output voltage	V <sub>OH</sub>	0.9 V <sub>CC</sub>	-	V	I <sub>OH</sub> = -1 mA
Low level output voltage	V <sub>OL</sub>	-	0.1 V <sub>CC</sub>	V	I <sub>OL</sub> = 1 mA
High level input voltage	V <sub>IH</sub>	0.8 V <sub>CC</sub>	-	V	$\overline{ST}$ terminal
Low level input voltage	V <sub>IL</sub>	-	0.2 V <sub>CC</sub>	V	$\overline{ST}$ terminal
Input current	I <sub>IH</sub>	-	10	μA	V <sub>IN</sub> = V <sub>CC</sub>
	I <sub>IL</sub>	-10	-	μA	V <sub>IN</sub> = GND
Output disable time	t <sub>stp</sub>	-	100	ns	$\overline{ST}$ terminal High → Low
Output enable time	t <sub>sta</sub>	-	3	ms	$\overline{ST}$ terminal Low → High
Input pull-up resistance	R <sub>UP</sub>	1	-	MΩ	V <sub>CC</sub> =3.3 V, at +25 °C

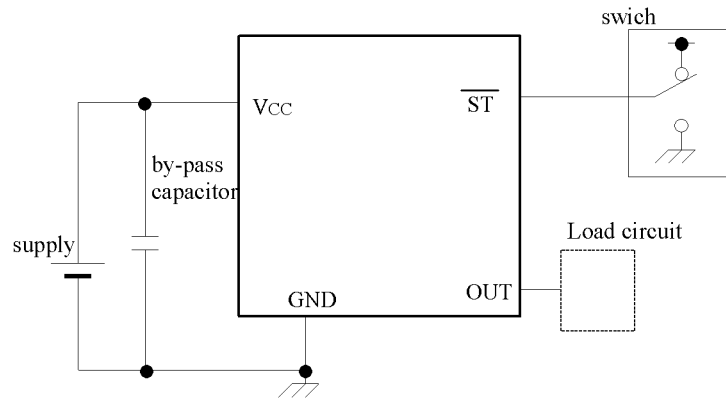
Refer to [6] Test circuit [7] Timing chart

◆ Reference : Current consumption Typ. Value ( V<sub>CC</sub> = 3.3 V, T<sub>use</sub> = +25 °C )



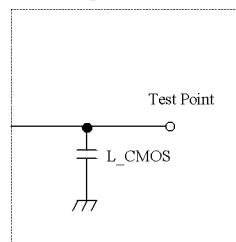
## [ 6 ] Test circuit

### 1) Waveform observation

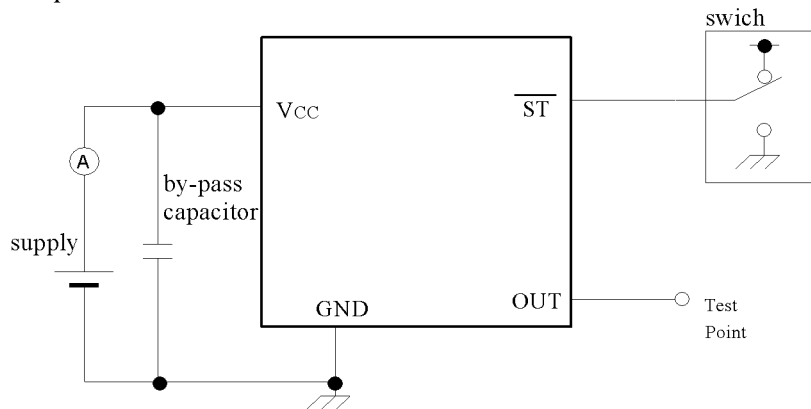


Load circuit

load capacitance



### 2) Current consumption



\*Current consumption under the disable function should be  $\overline{ST} = \text{GND}$ .

### 3) Condition

#### (1) Oscilloscope

- Band width should be minimum 5 times higher (wider) than measurement frequency.
- Probe earth should be placed closely from test point and lead length should be as short as possible.

\* Recommendable to use miniature socket. (Don't use earth lead.)

#### (2) L\_CMOS also includes probe capacitance.

(3) By-pass capacitor (0.01  $\mu\text{F}$  to 0.1  $\mu\text{F}$ ) is placed closely between Vcc and GND.

(4) Use the current meter whose internal impedance value is small.

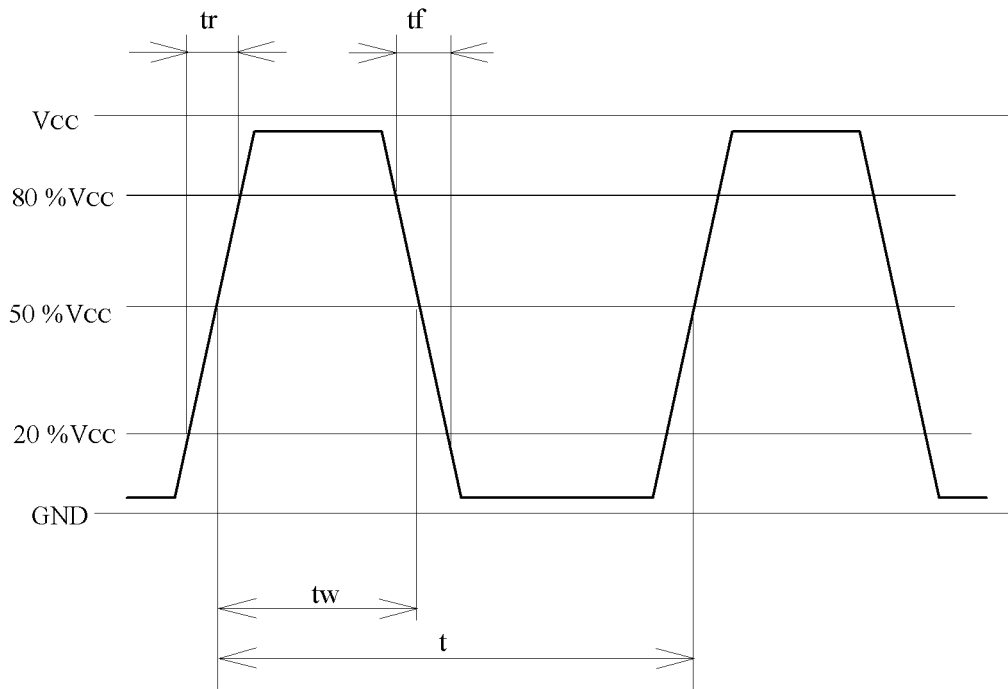
#### (5) Power supply

- Start up time (0 %Vcc  $\rightarrow$  90 %Vcc) of power source should be more than 150  $\mu\text{s}$ .
- Impedance of power supply should be as lowest as possible.

## [ 7 ] Timing chart

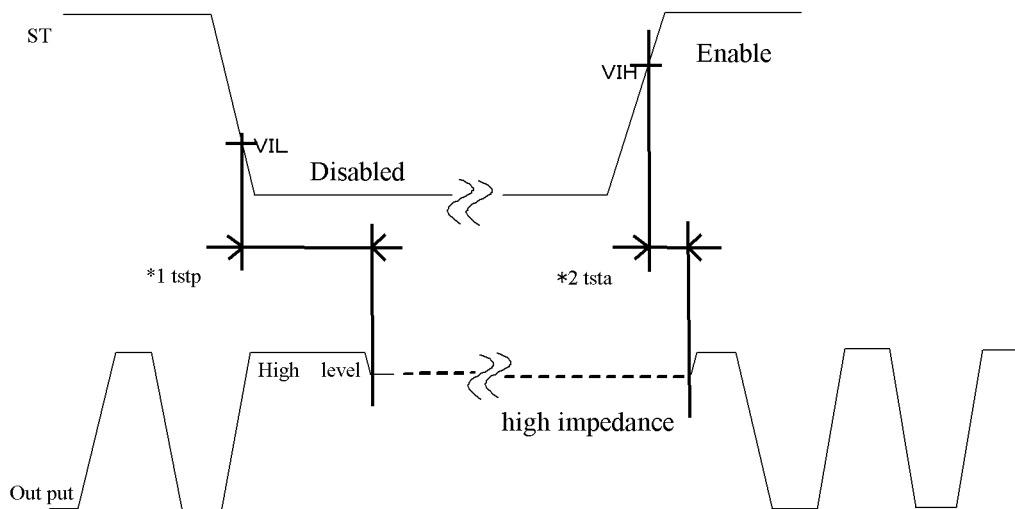
### 1) C-MOS load

$$\text{SYM} = \frac{t_w}{t} \times 100 (\%)$$



### 2) $\overline{\text{ST}}$ function and timing

$\overline{\text{ST}}$ function	Osc. circuit	Output status
High or Open	Oscillation	Specified frequency is output : Enable
Low	Oscillation stop	Output becomes high impedance : Disable



\*1 The time taken from  $\overline{\text{ST}} = V_{IL}$  to output = Disable (high impedance)

\*2 The time taken from  $\overline{\text{ST}} = V_{IH}$  to output = Start

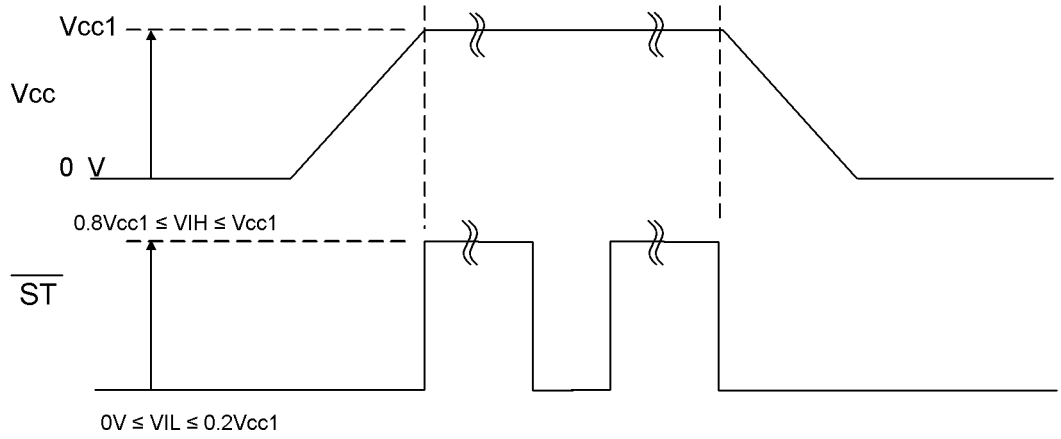
Output start :  $V_{OH} \geq 80\% V_{CC}$ ,  $V_{OL} \leq 20\% V_{CC}$ ,  $f_{out} = f_o \pm 1000 \times 10^{-6}$



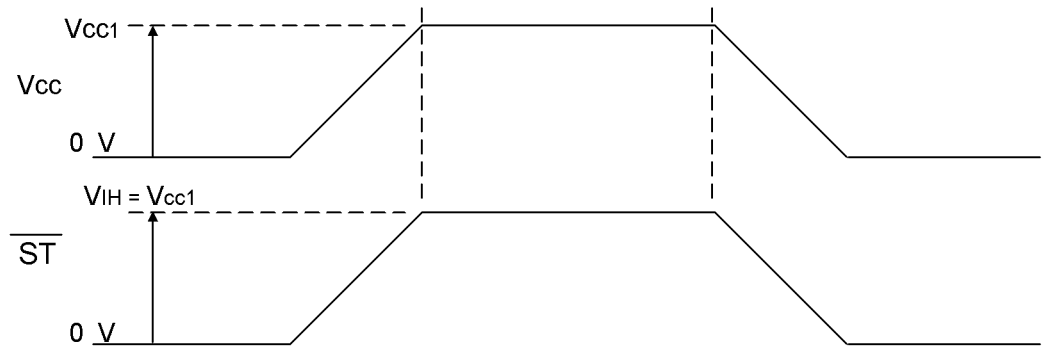
### 3) $\overline{ST}$ Control timing

$\overline{ST}$  function is used on the voltage below supply voltage.

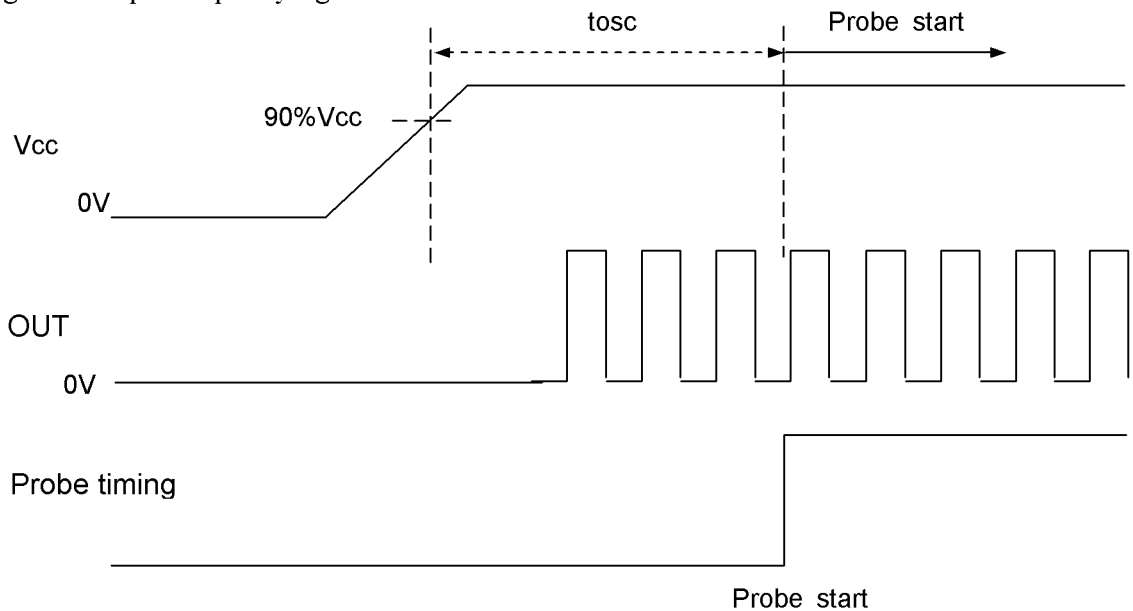
$\overline{ST}$  control timing differs from  $V_{cc}$  control timing



$\overline{ST}$  terminal is connected to  $V_{cc}$  terminal



### 4) Timing of an output frequency signal



## [ 8 ] Environmental and mechanical characteristics

(The company evaluation condition We evaluate it by the following examination item and examination condition.)

No.	Item	Value *1		Test Conditions
		$\Delta f / f *2$ [ $1 \times 10^{-6}$ ]	Electrical characteristics	
1	High temperature storage	*3 $\pm 20$	Satisfy Item [5] after test.	+125 °C × 1 000 h
2	Low temperature storage	*3 $\pm 10$		-40 °C × 1 000 h
3	High temperature bias	*3 $\pm 20$		+125 °C × V <sub>CC</sub> Max. × 1 000 h
4	Low temperature bias	*3 $\pm 10$		-40 °C × V <sub>CC</sub> Max. × 1 000 h
5	Temperature humidity bias	*3 $\pm 10$		+85 °C × 85 %RH × V <sub>CC</sub> Max. × 1 000 h
6	Temperature cycle	*3 $\pm 10$		-40 °C ↔ +125 °C 30 min. at each temperature 1000 cycles
7	Resistance to soldering heat	$\pm 5$		Convection reflow soldering furnace (3 time) Ref. IPC/JEDEC J-STD-020D.1
8	Shock	$\pm 3$		150 g dummy Jig (Epson Toyocom Standard) drop from 1 500 mm height on the Concrete 3 directions 10 times.
9	Vibration	$\pm 2$		10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s <sup>2</sup> 10 Hz → 500 Hz → 10 Hz 15 min./cycle 6 h (2 hours , 3 directions)
10	Seal	$1 \times 10^{-9}$ Pa·m <sup>3</sup> /s		He leakage detector
11	Solderability	Termination must be 95 % covered with fresh solder		Dip termination into solder bath at +235 °C $\pm 5$ °C for 5 s. (Using Rosin Flux)
12	Pull - off	No peeling-off at a solder part		10 N press for 10 s $\pm 1$ s Ref. EIAJ ED-4702

< Notes >

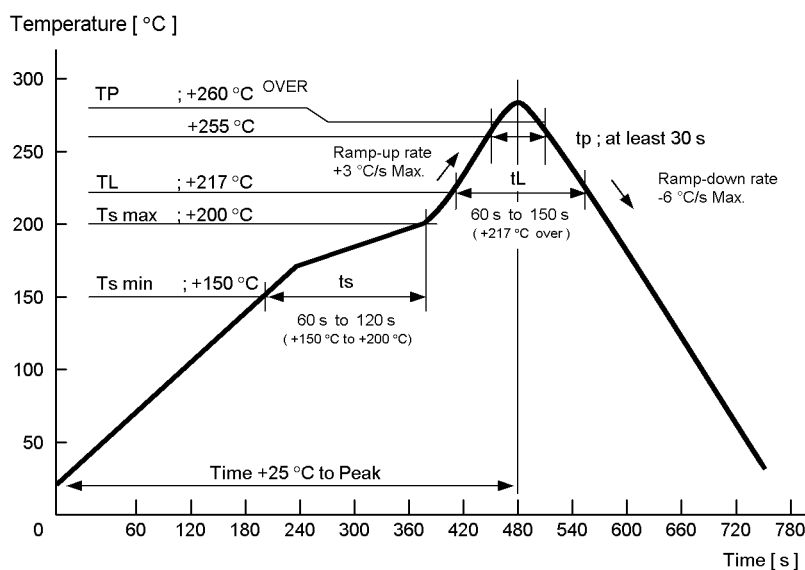
\*1 Each test done independently.

\*2 Measuring 2 h to 24 h later leaving in room temperature after each test.

\*3 Initial value shall be measured after 24 h storage at room temperature after pre-conditioning.

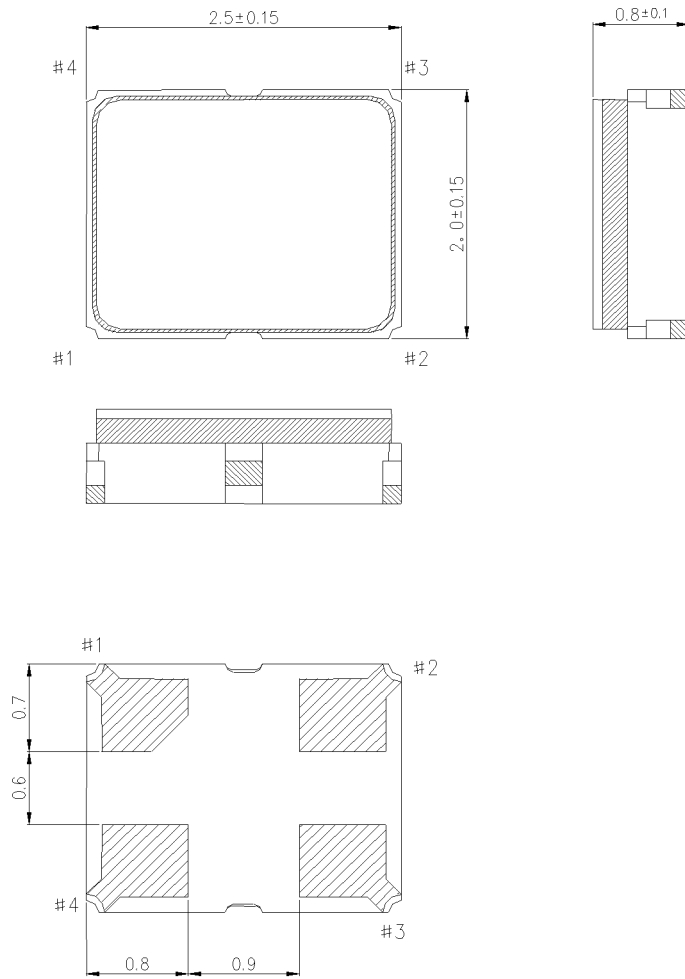
Pre-conditioning: Reflow (3 time)

Convection reflow condition (IPC/JEDEC J-STD-020D.1)



# [ 9 ] Dimensions and marking layout

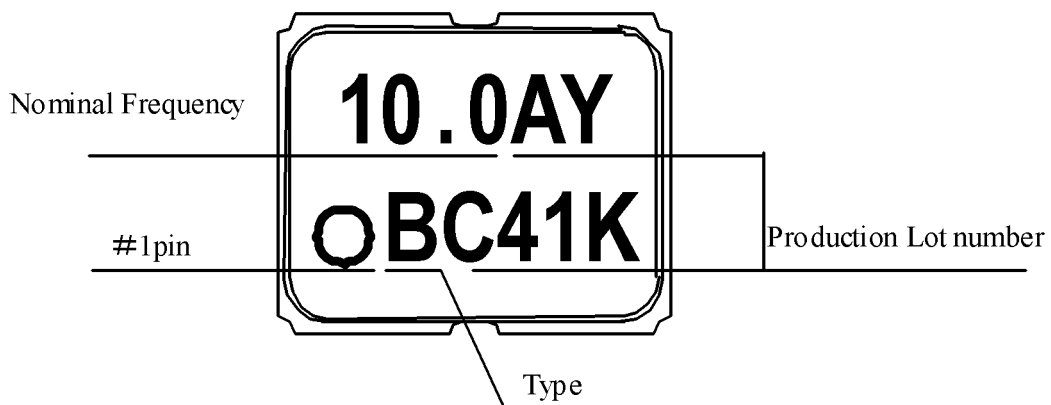
## 1) Dimensions



Terminal treatment : Au plating

Unit : mm

## 2) Marking layout



- ◆ The above marking layout shows only marking contents and their approximate position and it is not for font, size and exact position.
- ◆ Output frequency shall indicate 4 digits (include decimal point), if the value of frequency over 4 digits, the least significant digits will be omitted.

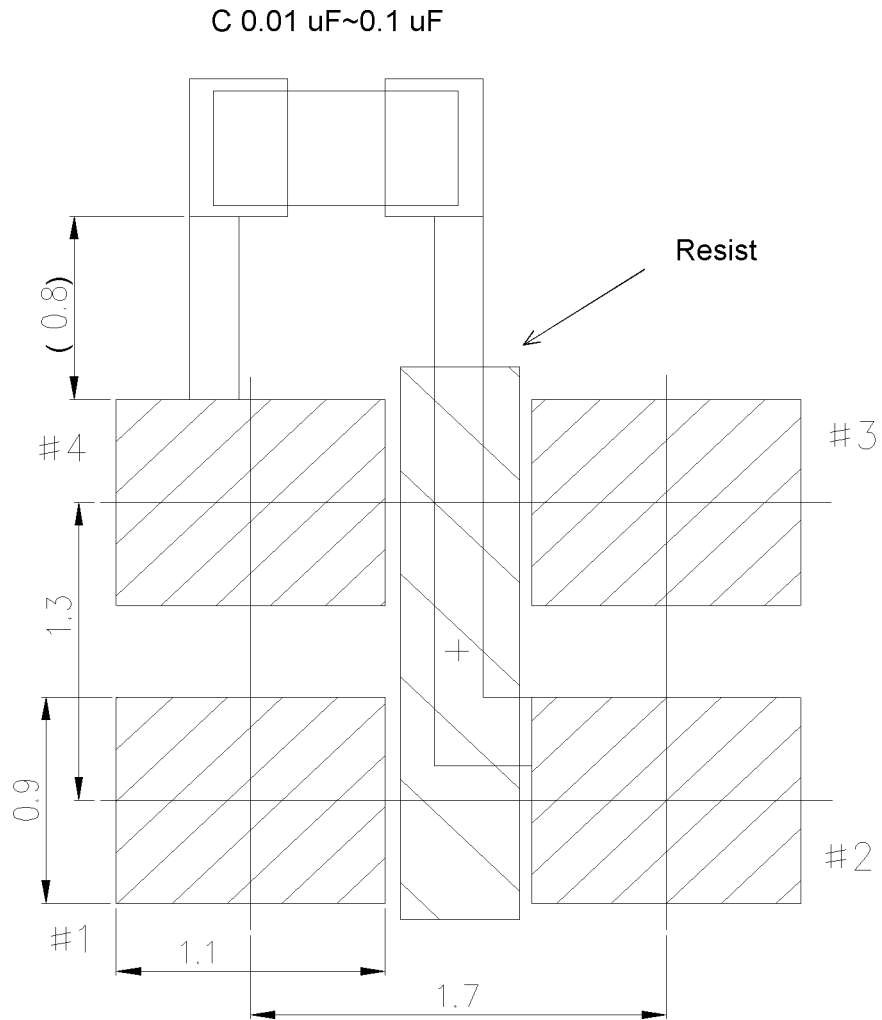
## [ 10 ] Notes

- 1) This device is made with C-MOS IC.  
Please take necessary precautions to prevent damage due to electrical static discharge.
- 2) Seiko Epson recommends a 0.01  $\mu\text{F}$  to 0.1  $\mu\text{F}$  capacitor must be connected near Vcc between Vcc and GND to obtain stable operation and protect against power line ripple.
- 3) Vcc and GND pattern shall be as large as possible so that high frequency impedance shall be small.
- 4) Seiko Epson cannot recommend to put filtering element into power line so as to reduce noise. Oscillator might be unstable oscillation because high frequency impedance of power line become higher. When use filtering element, please verify electrical construction and or element's spec.
- 5) Seiko Epson doesn't recommend to power on from intermediate electric voltage or extreme fast power on, Those powering conditions may cause no oscillation or abnormal oscillation.
- 6) Power ripple: 200 mV P-P max. Start up time (0 %Vcc $\rightarrow$ 90 %Vcc) of power source should be more than 150  $\mu\text{s}$ .
- 7) A long output line may cause irregular output, so try to make the output line as short as possible.
- 8) Other high-level signal lines may cause incorrect operation, so please do not place high level signal line close to this device.
- 9) This device contains a crystal resonator, so please don't expose excessive shock or vibration.  
Seiko Epson recommends store device under normal temperature and humidity to keep the specification.
- 10) An automatic insertion is available, however, the internal crystal resonator might be damaged in case that too much shock or vibration is applied by machine condition.  
Be sure to check your machine condition in advance.
- 11) Ultrasonic cleaning can be used on the SG-210SCBA, however, since the oscillator might be damaged under some conditions, please exercise in advance.
- 12) Seiko Epson recommends to use and store under room temperature and normal humidity to secure frequency accuracy and prevent moisture.
- 13)  $\overline{\text{ST}}$  -pin has pull-up resistor internally. The resistor value is switched depending on input voltage.  
Please refer to electrical characteristics.
- 14) Lid is electrically connected to GND.  
Please don't apply electrical voltage.

# [ 11 ] Recommendable patterning

The soldering pad sample indicated as like following:

Soldering position (Unit : mm)



# TAPING SPECIFICATION

## I . Application

This standard will apply to 2.5×2.0 Ceramic package.

Spec : CG package

## II . Contents

Item No.	Item	Page
[1]	Taping specification	1 to 2
[2]	Inner carton	3
[3]	Shipping carton	
[4]	Marking	4
[5]	Quantity	
[6]	Storage environment	
[7]	Handling	

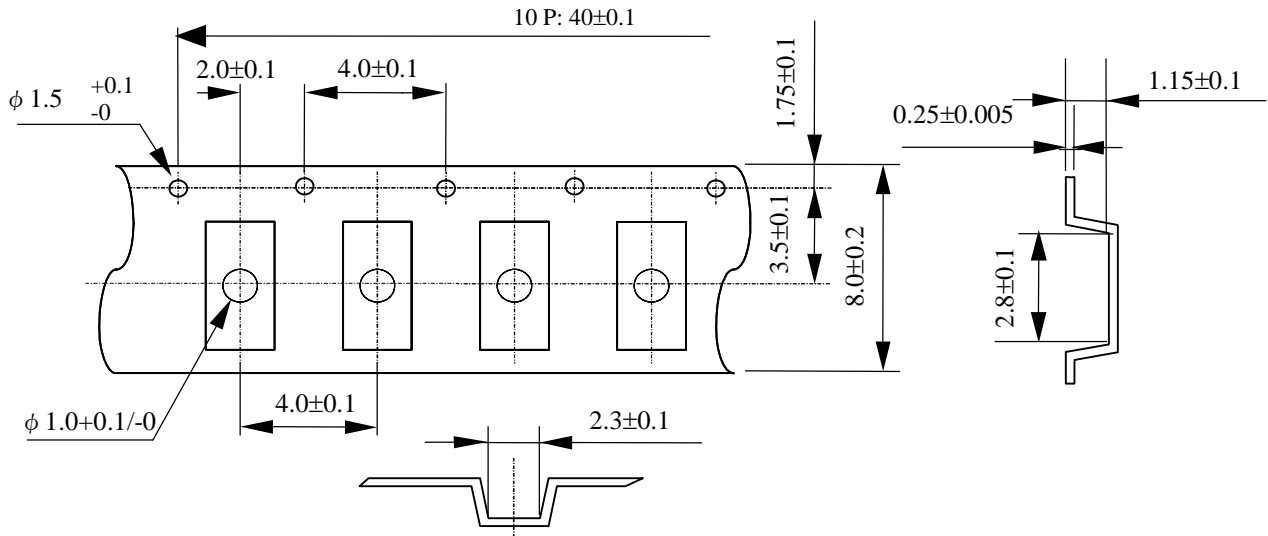
[1] Taping specification

Subject to 「EIA-481」 and 「IEC-60286」

(1) Tape dimensions

Material of the carrier tape : P S

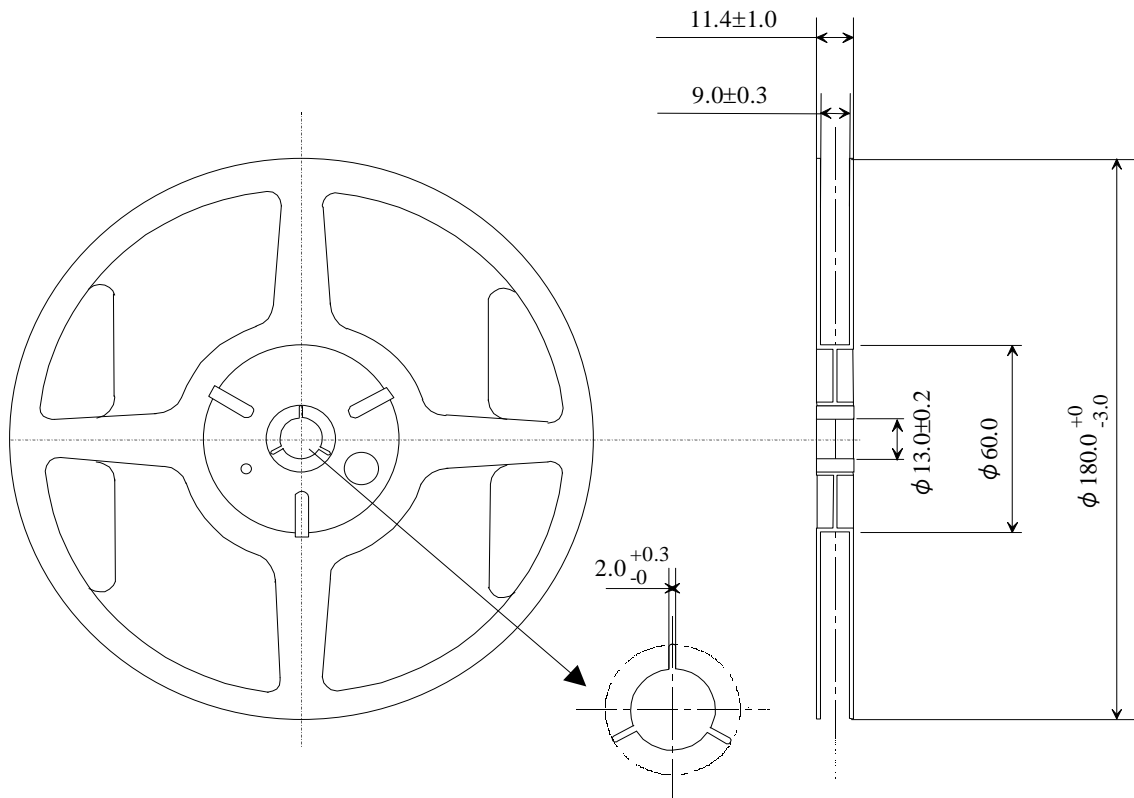
Material of the top tape : PET+PE



Unit : mm

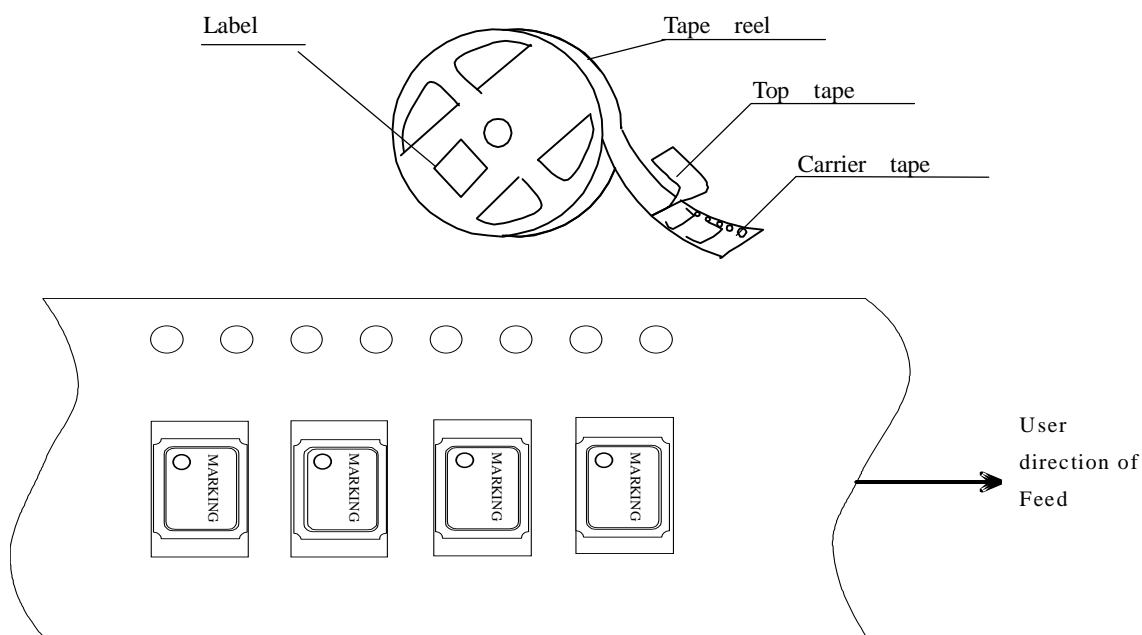
(2) Reel dimensions

Material of the reel : Conductive polystyrene

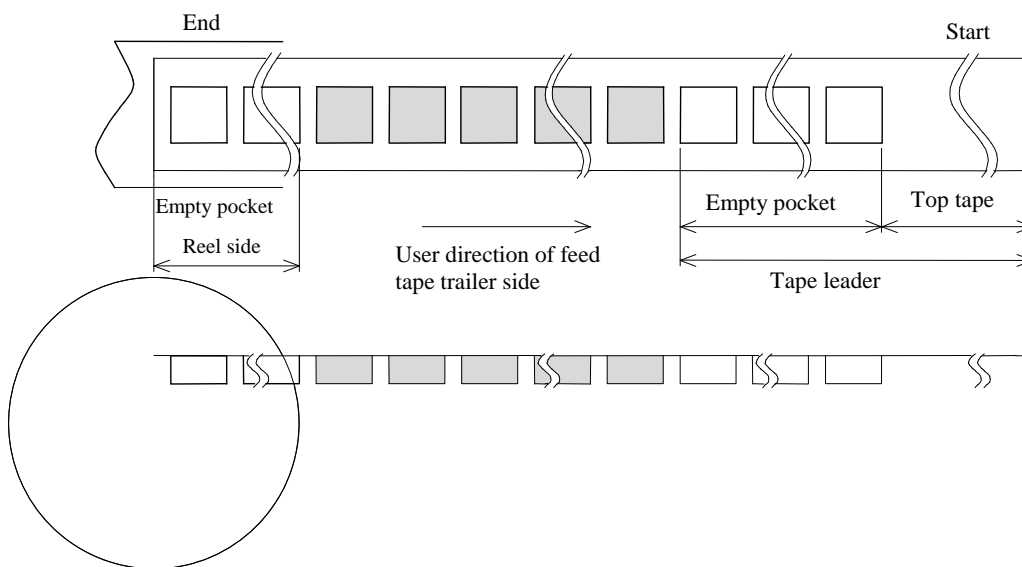


(3) Packing

① Tape & reel



② Start & end point



Item		Empty space
Tape leader	Top tape	Min. 1 000 mm
	Carrier tape	Min. 160 mm
Tape trailer	Top tape	Min. 0 mm
	Carrier tape	Min. 160 mm

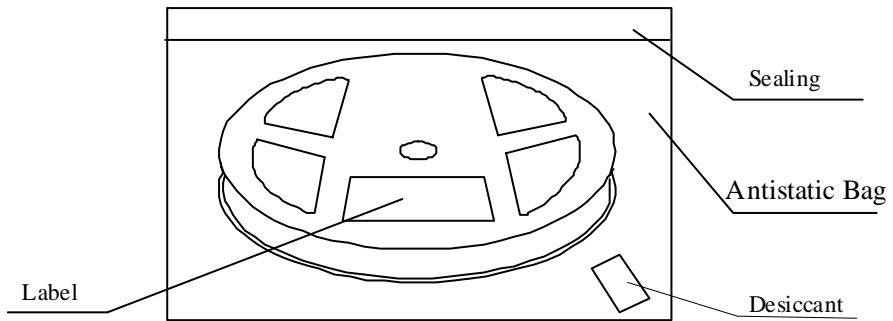
(4) Peel force of the cover tape

- ① angle : cover tape during peel off and the direction of unreeling shall be 165° to 180°.
- ② peel speed : 300 mm / min.

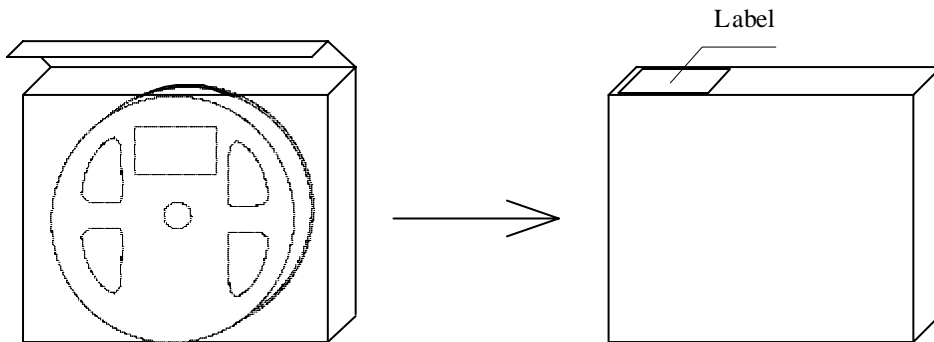


[2] Inner carton

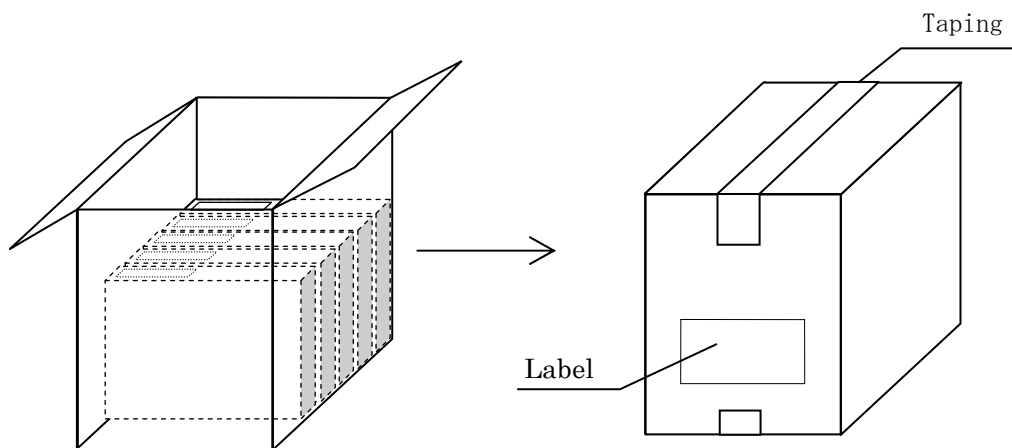
a) Packing to antistatic bag



b) Packing to inner carton



[3] Shipping carton



#### [4] Marking

##### (1) Reel marking

- Reel marking shall consist of :

- 1) Parts name
- 2) Quantity
- 3) Manufacturing date or symbol
- 4) Manufacturer's date or symbol
- 5) Others (if necessary)

##### (2) Inner carton marking

- Same as reel marking.

##### (3) Shipping carton marking

- Shipping carton marking shall consist of :

- 1) Parts name
- 2) Quantity

#### [5] Quantity

- 3 000 pcs./reel

#### [6] Storage environment

- (1) Before open the packing, we recommend to keep less than +30 °C and 85 %RH of Humidity, and to use it less than 6 months after delivery.
- (2) We recommend to open Package in immediately before use. After open Package, We recommend to keeps less than 6 month. No need dry air before soldering work if it is less than temperature +30 °C, 85 humidity %RH.
- (3) Not to expose the sun.
- (4) Not to storage with some erosive chemicals.
- (5) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

#### [7] Handling

- To handle with care to prevent the damage of tape, reel and products.

- PROCESS QUALITY CONTROL -

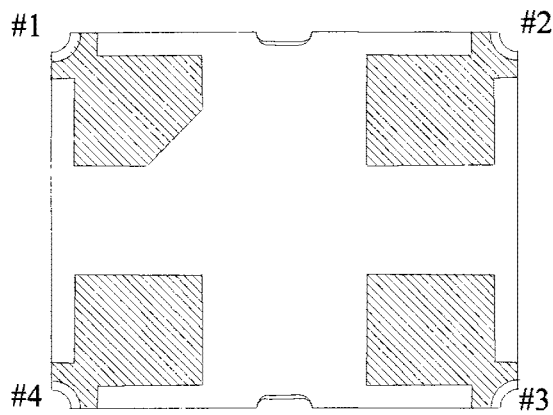
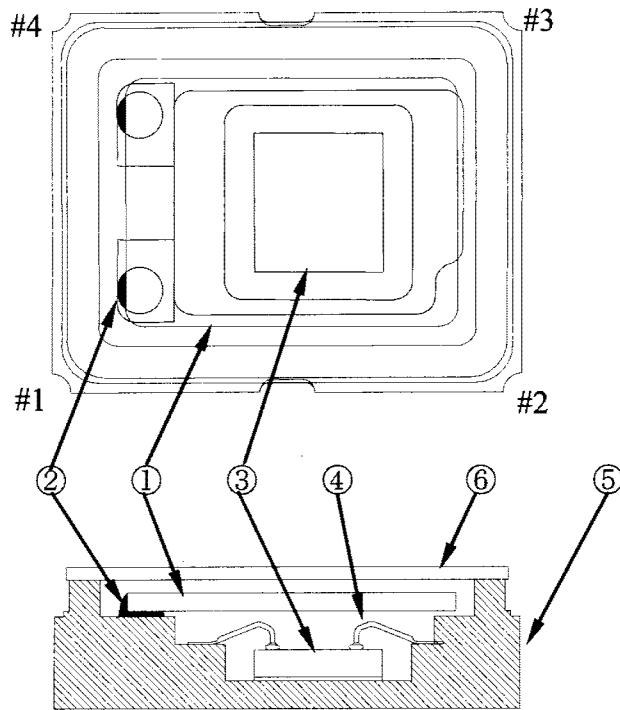
No. SG210S\*BA - 00 - ASE - 1

Crystal Oscillator SG-210S\*BA

'13. 6.12

Manufacturing process chart		No	Process	Setion	Standards	Inspection control item	Instruments	Inspection methods	Record
	1	In-coming inspection	Inspection Section	Purchasing Specification Incoming Inspection Standard	Appearance Dimension	MS	Sampling	Data sheet	
	2	Creaning	China Plant (Production Section)	Manufacturing Instruction Sheet	-	-	-	Data sheet	
	3	Sputter	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	100% Inspection	Data sheet	
					Peeling Strength	Scratch	Sampling	Data sheet	
					Frequency	CI Meter	Sampling	Data sheet	
	4	Parts Mounting	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	MS	Sampling	Data sheet	
	5	hardening	China Plant (Production Section)	Manufacturing Instruction Sheet	-	-	-	-	
	6	Wire bonding	China Plant (Production Section)	Manufacturing Instruction Sheet	Bonding strength	Gauge	Sampling	Data sheet	
					Appearance	MS	100% Inspection	Data sheet	
	7	Crystal mounting	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	MS	100% Inspection	Data sheet	
	8	hardening	China Plant (Production Section)	Manufacturing Instruction Sheet	-	-	-	-	
	9	Frequency Adjusting	China Plant (Production Section)	Manufacturing Instruction Sheet	Frequency	Counter	100% Inspection	Data sheet	
	10	Temporary Hermetic Sealing	China Plant (Production Section)	Manufacturing Instruction Sheet	-	-	-	-	
	11	Baking	China Plant (Production Section)	Manufacturing Instruction Sheet	-	-	-	-	
	12	Hermetic Sealing	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	MS	Sampling	Data sheet	
	13	Heating	China Plant (Production Section)	Manufacturing Instruction Sheet	-	-	-	-	
	14	Leakage	China Plant (Production Section)	Manufacturing Instruction Sheet	Leakage Inspection	M/C	100% Inspection	Data sheet	
	15	Marking	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	MS	Sampling	Data sheet	
	16	LDL Inspection	China Plant (Production Section)	Manufacturing Instruction Sheet	Characteristic Inspection	M/C	100% Inspection	Data sheet	
	17	Electrical Characteristic	China Plant (Production Section)	Manufacturing Instruction Sheet	Electrical Characteristic	M/C	100% Inspection	Data sheet	
	18	Temp Characteristic	China Plant (Production Section)	Manufacturing Instruction Sheet	Temp Characteristic Inspection	M/C	Sampling	Data sheet	
	19	High temp Ele Characteristic	China Plant (Production Section)	Manufacturing Instruction Sheet	Electrical Characteristic	M/C	100% Inspection	Data sheet	
	20	Visual inspection	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	MS	100% Inspection	Data sheet	
21	Outgoing inspection	China Plant (Inspection Section)	Delivery Specifications Outgoing Inspection Standard	Electrical Characteristic Appearance	M/C MS	Sampling	Data sheet		
22	Taping	China Plant (Production Section)	Manufacturing Instruction Sheet	Tape peeling Strength	M/C	Sampling	Data sheet		
				Frequency check Appearance	M/C	100% Inspection	Data sheet		
23	Packing	China Plant (Production Control Section)	Manufacturing Instruction Sheet Daily Shipping List	Customers Type Quantity	-	-	Delivery Slip		

# Structure diagram SG-210S\*B



## LIST

Name of part		Material
①	Crystal chip	AT cut
②	Crystal adhesive	Ag paste
③	IC	C-MOS
	IC conductive adhesive	Ag paste
④	Bonding wire	Au
⑤	Package	Ceramic ( $Al_2O_3$ )
⑥	Cap	Cover

# RELIABILITY TEST DATA

## Product Name : SG-210\*\*B series ( High temperature )

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition . No. OUT8-34-0097-003E

No.	ITEM	TEST CONDITIONS	VALUE *1		TEST	FAIL
			D f / f *2 [1 ± 10 <sup>-6</sup> ]	Electrical characteristics	Qty [ n ]	Qty [ n ]
1	High temperature storage	+125 °C × 1 000 h	*3 ± 20	Satisfy specification after test	22	0
2	Low temperature storage	-40 °C × 1 000 h	*3 ± 10		22	0
3	High temperature bias	+125 °C × Spec bias × 1 000 h	*3 ± 20		22	0
4	Low temperature bias	-40 °C × Spec bias × 1 000 h	*3 ± 10		22	0
5	Temperature humidity bias	+85 °C × 85 %RH × Spec bias × 1 000 h	*3 ± 10		22	0
6	Temperature cycle	-40 °C ⇄ +125 °C 30 min at each temp. 1000 cycles	*3 ± 10		22	0
7	Resistance to soldering heat	For convention reflow soldering furnace (3 times) Ref. IEC/JEDEC J-STD-020D.1	± 5		22	0
8	Shock	100 g dummy (EPSON Standard) drop from 1 500 mm height on to the concrete 3 directions 10 times	± 3		22	0
9	Vibration	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s <sup>2</sup> 10 Hz → 500 Hz → 10 Hz 15 min / cycle 6 h ( 2 h × 3 directions )	± 2		22	0
10	Seal	He leakage detector	1 × 10 <sup>-9</sup> Pa·m <sup>3</sup> /s MAX	11	0	
11	Solderability	Dip termination into solder bath at +235 °C ± 5 °C for 5 s (Using Rosin Flux)	Termination must be 95 % covered with fresh solder	11	0	
12	Pull-off	10N press for 10s ± 1s Ref.EIAJ ED-4702	No Peeling-off at a solder part	11	0	

### Notes

1. \*1 Each test done independently.
2. \*2 Measuring 2 h to 24 h later leaving in room temperature after each test.
3. \*3 Initial value shall be measured after 24 h storage at room temperature after pre-conditioning.  
Pre-conditioning: Reflow (3 time)

**Product Name : SG-210\*\*B series ( High temperature )**

$\Delta f/f$

No. OUT8-34-0097-004E

